

Test Report

HSI-CHIN ELECTRONICS CO., LTD.
 4F, NO. 194, SEC. 3, TA TUNG RD., HSI CHIH CITY,
 TAIPEI HSIEN, TAIWAN R.O.C.

Report No. : CE/2005/A0532
 Date : 2005/10/12
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The following merchandise was (were) submitted and identified by the client as :

Type of Product : USB SHELL NICKEL PLATED (COPPER ALLOY)
Style/Item No : USB SHELL SERIES
Buyer/Order No : LITE-ON TECHNOLOGY CORP.
Sample Received : 2005/10/04
Testing Date : 2005/10/04 TO 2005/10/12

Conclusion : The test results of Pb, Cd and Hg for the submitted sample comply with the requirements of RoHS (2002/95/EC).


Test Result

PART NAME NO.1 : SILVER COLORED METAL (PLEASE REFER TO THE PHOTO
 PART NAME NO.2 : SILVER COLORED PLATING (PLEASE REFER TO THE PHOTO ATTACHED)

PASS

Test Item (s):	Unit	Method	MDL	Result		Limit of ROHS
				No.1	No.2	
Chromium VI (Cr+6)	**	As per IEC 111 Section 9 method.	0.02µg/g with 50 cm ² surface area	---	Negative	-
Cadmium (Cd)	ppm	ICP-AES after reference to EN 1122, method B:2001 or other acid digestion.	2	N.D.	---	100
Mercury (Hg)	ppm	ICP-AES after reference to US EPA 3052 or other acid digestion.	2	N.D.	---	1000
Lead (Pb)	ppm	ICP-AES after reference to US EPA 3050B or other acid digestion.	2	48.3	---	1000

NOTE: (1) N.D. = Not detected (<MDL)
 (2) ppm = mg/kg
 (3) MDL = Method Detection Limit
 (4) " - " = No Regulation
 (5) ** = Qualitative analysis (No Unit)


 Daniel Yeh, M.R. / Operation Manager
 Signed for and on behalf of
 SGS TAIWAN LTD.

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